

IFND89

N-Channel Silicon Junction Field-Effect Transistor with Diodes

Power Supply Voltage down to 0.9 V & Low Current Operation with Ultra-High Impedance

- Hearing Aids, Mini Microphones
- Infrared Detector Amplifiers
- Low-Current, Low-Voltage, Battery Powered Amplifiers
- High-Gain, Low-Noise Amplifiers

Absolute maximum ratings at $T_A = 25^\circ\text{C}$

Reverse Gate Source & Gate Drain Voltage	-15V
Continuous Forward Gate Current	10 mA
Continuous Device Power Dissipation	250 mW
Power Derating	2 mW/ $^\circ\text{C}$
Storage Temperature Range	-65 $^\circ\text{C}$ to +150 $^\circ\text{C}$

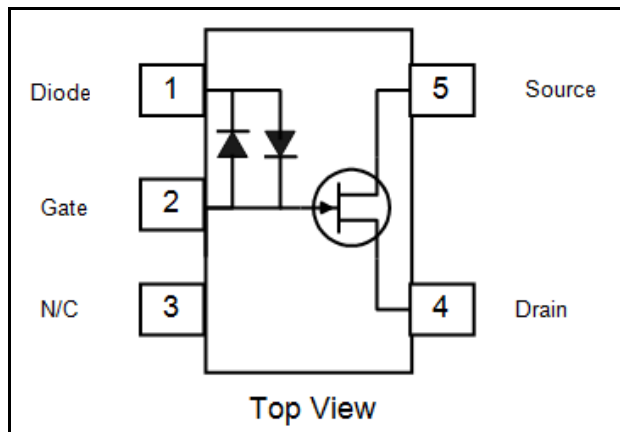
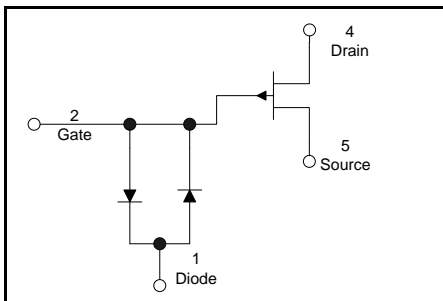
At 25 $^\circ\text{C}$ free air temperature Static Electrical Characteristics		IFND89		Process NJ14EU	
		Min	Max	Unit	Test Conditions
Gate Source Breakdown Voltage	$V_{(BR)GSS}$	-15		V	$I_G = -1 \mu\text{A}, V_{DS} = 0 \text{ V}$
Gate Reverse Current	I_{GSS}		-0.10	nA	$V_{GS} = -10 \text{ V}, V_{DS} = 0 \text{ V}$
Gate Source Cutoff Voltage	$V_{GS(OFF)}$	-0.2	-0.9	V	$V_{DS} = 1.3 \text{ V}, I_D = 1 \mu\text{A}$
Gate Source Cutoff Voltage (Note1)	$V_{GS(OFF)}$	-0.2	-2.5	V	$V_{DS} = 3.3 \text{ V}, I_D = 1 \mu\text{A}$
Drain Saturation Current (pulsed)	I_{DSS}	50	1000	μA	$V_{DS} = 0.92 \text{ V}, V_{GS} = 0 \text{ V}$
Gate Diode Breakdown Voltage+	$V_{(BR)Gdiode}$	0.4	0.8	V	$I_G = 10 \mu\text{A}, V_{DS} = 0 \text{ V}$
Gate Diode Breakdown Voltage-	$V_{(BR)Gdiode}$	-0.4	-0.8	V	$I_G = -10 \mu\text{A}, V_{DS} = 0 \text{ V}$

Dynamic Electrical Characteristics

Common-Source Forward Transconductance	g_{fs}	0.6	2.25	mS	$V_{DS} = 1.3 \text{ V}, V_{GS} = 0 \text{ V}$	$f = 1 \text{ kHz}$
Gate-Source Input Capacitance	C_{GS}		5	pF	$V_{DS} = 1.3 \text{ V}, V_{GS} = 0 \text{ V}$	$f = 1 \text{ MHz}$
Drain-Source On Resistance	$r_{ds(on)}$		3000	Ω	$V_{DS} \leq 0.1 \text{ V}, I_D \leq 100 \mu\text{A}$	$f = 1 \text{ kHz}$
Equivalent Short Circuit Input Noise Voltage	\bar{e}_N		12	$\frac{\text{nV}}{\sqrt{\text{Hz}}}$	$V_{DS} = 1.3 \text{ V}, V_{GS} = 0 \text{ V}$	$f = 100 \text{ Hz}$

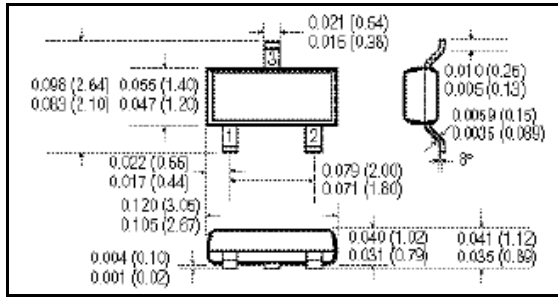
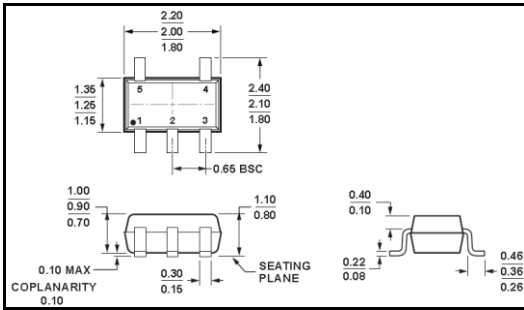
Notes: 1. Internal diodes are not connected.

IFND89
SC70-5
SOT-353



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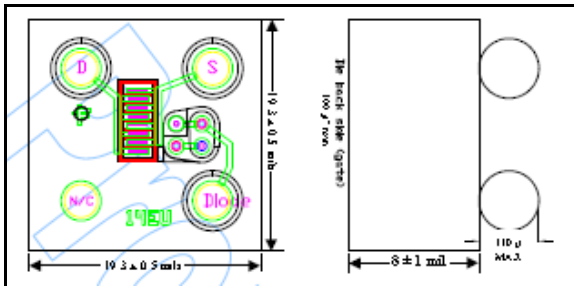
Dimensions in Inches (mm)

SC70-5: IFND89

1-Diodes, 2-Gate, 3-N/C, 4-Source, 5-Drain

SOT-23: SMPD89

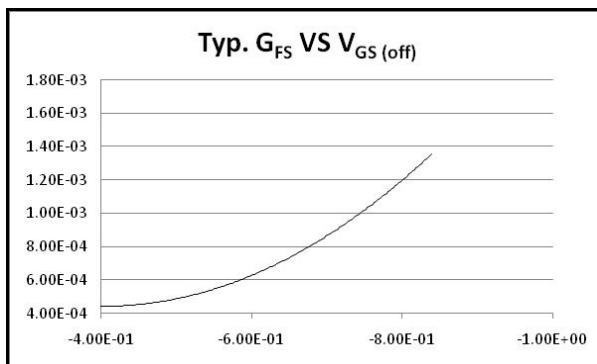
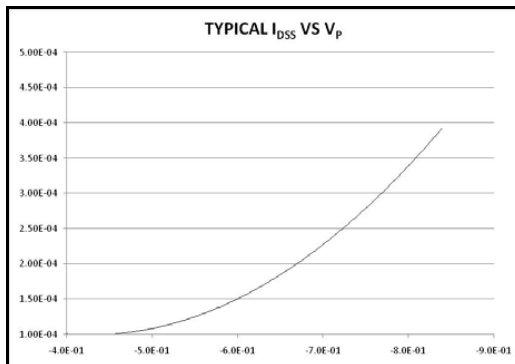
1-Source, 2-Drain, 3-Gate, Diodes-N/C



Flip-Chip-Bump: IFND89BP

1-Drain, 2-Source, 3-Diodes, 4-N/C, Top side-Gate, Dimensions in Mils. Marking: There is a dot lasered on the top above the N/C ball for alignment.

Typical Performance Curves



Typ. Noise Voltage:
@ $V_{DS} = 1.3$ Volts & $I_D = I_{DSS}$
(nanoV per root Hz)

10 Hz	100 Hz	1K Hz	10K Hz	100K Hz
6.8	5.8	4.9	4.6	4.5

